

FORM PTO-1449
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
NIP-155-02

SERIAL NO.

10/000,683

LIST OF DOCUMENTS CITED BY APPLICANT
(Use several sheets if necessary)

APPLICANT

M. NAGASE et al

FILING DATE

December 4, 2001

GROUP

1764

U.S. PATENT DOCUMENTS

* EXAMINER INITIAL		DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
ADD	AA	5,619,545	04/08/97	Grummon et al	376	195	
ADD	AB	5,764,717	06/09/98	Rootham	376	314	
ADD	AC	5,805,654	09/08/98	Wood et al	376	313	
ADD	AD	5,434,331	07/95	Barkatt et al	588	1	
ADD	AE	5,489,735	02/06/96	D'Muhala et al	588	1	
ADD	AF	4,729,855	03/08/88	Murray et al	134	2	
ADD	AG	4,508,641	04/02/85	Hanulik	588	3	
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
ADD	AL	9-113690	05/02/97	Japan		partial	<input checked="" type="checkbox"/>	<input type="checkbox"/>
ADD	AM	10-123293	05/15/98	Japan		partial	<input checked="" type="checkbox"/>	<input type="checkbox"/>
ADD	AN	62-250189	10/31/87	Japan		partial	<input checked="" type="checkbox"/>	<input type="checkbox"/>
ADD	AO	57-9885	10/19/82	Japan		partial	<input checked="" type="checkbox"/>	<input type="checkbox"/>
ADD	AP	63-253300	10/20/88	Japan			<input type="checkbox"/>	<input checked="" type="checkbox"/>

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

ADD	AR	A Full System Decontamination of the Oskarshamn 1 BWR", PROCEEDINGS OF THE INTERNATIONAL CONFERENCE, 4/27/94, pp. 203-210					
	AS						
	AT						

EXAMINER

Alex Droschuk

DATE CONSIDERED

6/24/04

* EXAMINER: Initial reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. NIP-155-02	SERIAL NO. 10/000,083	
LIST OF DOCUMENTS CITED BY APPLICANT <i>(Use several sheets if necessary)</i>				APPLICANT M. NAGASE et al		
				FILING DATE December 4, 2001	GROUP 1764	
U.S. PATENT DOCUMENTS						
* EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE <i>(If Appropriate)</i>
AA						
AB						
AC						
AD						
AE						
AF						
AG						
AH						
AI						
AJ						
AK						
FOREIGN PATENT DOCUMENTS						
	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
AL	1-242792	09/27/89	Japan			<input type="checkbox"/> <input checked="" type="checkbox"/>
AM	6-99193	04/12/94	Japan			<input type="checkbox"/> <input checked="" type="checkbox"/>
AN	3-10919	02/14/91	Japan			<input type="checkbox"/> <input checked="" type="checkbox"/>
AO	9-510784	10/28/97	Japan			<input type="checkbox"/> <input checked="" type="checkbox"/>
AP						<input type="checkbox"/> <input type="checkbox"/>
OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, etc.)</i>						
AR						
AS						
AT						
EXAMINER <i>[Signature]</i>				DATE CONSIDERED 10/24/04		

* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.